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## **M1Or2B-03 [Invited]: Enhancement of Measurement Speed over 100 m/h in Reel-to-Reel Scanning Hall Probe Microscopy Using a Multi-Channel Array**

*Monday 22 July 2019 12:00 (30 minutes)*

In our previous study, we demonstrated that the reel-to-reel scanning Hall probe microscopy (RTR-SHPM) has a good advantage on the measurements of spatially resolved in-plane  $J_c$  distribution in a long length HTS tapes with a high spatial resolution along the tape width as well as the longitudinal direction. This is inevitable for a detection of localized defect in the tape, evaluation of an effective tape width, measurement of a very narrow tape and/or multi-filamentary tapes. However, one drawback of this method is its relatively low measurement speed around several tens meter per hour or less. In this study, we have succeeded in increasing the measurement speed significantly by introducing a multi-channel Hall probe array. Namely, we can increase the measurement speed  $N$  times faster by using a  $N$ -channel sensor array without losing the spatial resolution. We demonstrated a measurement speed of 108 m/h with a longitudinal spatial resolution of 1 mm by using a 3-channel Hall probe array. From the comparison between the previous single channel measurement and the 3-channel measurement, we confirmed that the multi-channel measurement allows us to obtain the same quality  $J_c$  mapping with 3 times faster measurement speed. We can increase the measurement speed further just by increasing the numbers of the channels. Therefore, we believe that this method can be a practical diagnostics for a long length HTS tapes even in an industrial scale.

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